

Notice of References Cited	Application/Control No. 10/526,115		Applicant(s)/Patent Under Reexamination KAARIO ET AL.	
	Examiner Van Kim T. Nguyen		Art Unit 2456	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0155413	08-2003	Kovesdi et al.	235/375
*	B	US-6,989,741	01-2006	Kenny et al.	340/505
	C	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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